MSKSEMI 美森科













ESD

TSS

MOV

GDT

PIFD

MS1045-04F

Product specification





Features

- IEC 61000-4-2 Level 4 ESD Protection
 - ±12kV Contact Discharge
 - ±17kV Air Discharge
- IEC 61000-4-4 EFT Protection
 - 40A (5/50ns)
- IEC 61000-4-5 Surge
 - 4.5A (8/20us)
- RoHS compliance
- Protecting four I/O line
- Ultra-low Capacitance: 0.6pF (Typical)
- Low clamping voltage
- Low leakage current
- Solid-state silicon technology

Applications

- HDMI/USB2.0
- Monitors and flat panel displays
- 10/100/1000 ethernet
- Notebook computers
- SIM ports
- ATM interface

Pin Configuration and Functions

PACKAGE OUTLINE	Outline	Circuit Diagram		
	.0524P	10-20-40-50-		
	1 2 3 4 5			
DFN2510-10				

Pin	Name	Description	
1	IO	Connect to IO	
2	IO	Connect to IO	
3	GND	Connect to GND	
4	IO	Connect to IO	
5	IO	Connect to IO	
6	NC	NO Connection	
7	NC	NO Connection	
8	GND	Connect to GND	
9	NC	NO Connection	
10	NC	NO Connection	



Absolute Maximum rating

Over operating free-air temperature range otherwise

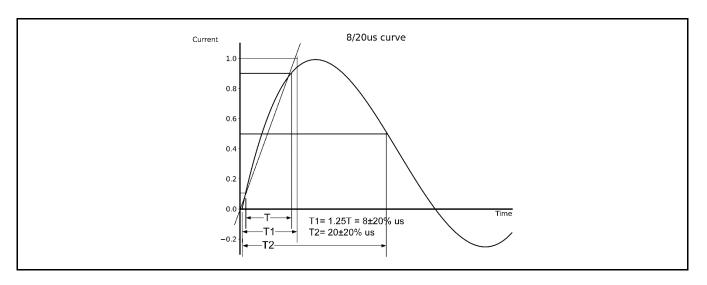
Parameters	Symbol	Min.	Max.	Unit
Peak pulse power (tp=8/20us)@25°C	P _{pk}	-	70	W
Peak pulse current (tp=8/20us)@25°C	IPP		4.5	А
ESD (IEC61000-4-2 air discharge) @25°C	Vesd	-	±17	kV
ESD (IEC61000-4-2 contact discharge) @25°C	V _{ESD}	-	±12	kV
Junction temperature	TJ	-	150	°C
Operating temperature	T _{OP}	-40	125	°C
Storage temperature	Тѕтс	-55	150	°C
Lead temperature	T _L	-	260	°C

Eletrical Characteristics At TA = 25℃ unless otherwise noted

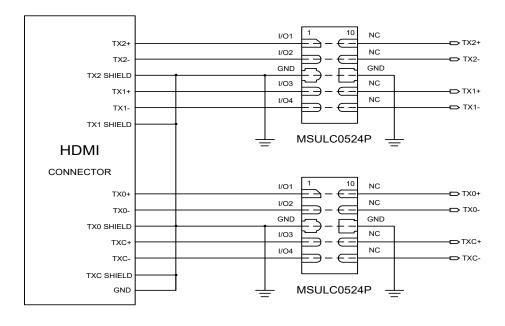
Parameters	Symbol	conditions	Min.	Тур.	Max.	Unit	
Reverse stand-off voltage	V _{RWM}				5.0	V	
Reverse Breakdown Voltage	V _{BR}	l₁= 1mA	6.0			V	
Reverse Leakage Current	I R	V _{RWM} =5V			1.0	uA	
Peak Pulse Current	Ірр	TP=8/20us@25°C			4.5	Α	
Clamping Voltage	V _{CL}	I _{PP} =1A; TP=8/20us		9.0	11.0	V	
Clamping Voltage	V _{CL}	I _{PP} =4.5A; TP=8/20us		12.0	15.0	V	
Junction capacitance	C _J	I/O pins to ground; V _R =0V; f = 1MHz		0.6		pF	
Sansasii sapadiland		Between I/O pins; V _R =0V; f = 1MHz		0.3		F.	



Typical Characteristic



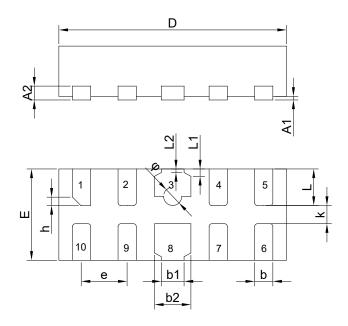
Typical Application



Typical HDMI Interface Application



Dimension (DFN2510-10)





Dimensions in Millimeter							
Symbol	Min.	Nom.	Max.	Symbol	Min.	Nom.	Max.
Α	0.500	0.550	0.600	D	2.450	2.500	2.550
A1	0.00	/	0.05	E	0.950	1.00	1.050
A2	0.122	0.152	0.200	е	0.450	0.500	0.550
b	0.150	0.200	0.250	h	0.080	0.120	0.150
b1	0.200	0.250	0.300	k	0.150	0.200	0.250
b2	0.350	0.400	0.450	L	0.350	0.400	0.450
L1	0.075 REF		L2	0.05 REF			
φ	0.150	0.200	0.250				

REEL SPECIFICATION

P/N	PKG	QTY
MS1045-04F	DFN2510-10	3000



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